

CERTIFICATE OF CORRECTION

PATENT NO. : 6,878,576 B1
APPLICATION NO. : 10/716991
DATED : April 12, 2005
INVENTOR(S) : Mears et al.

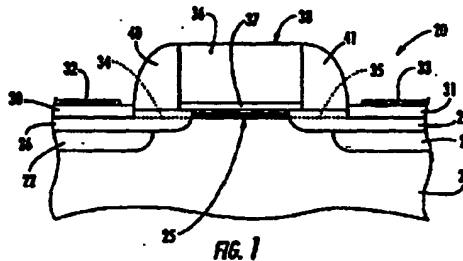
Page 1 of 4

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

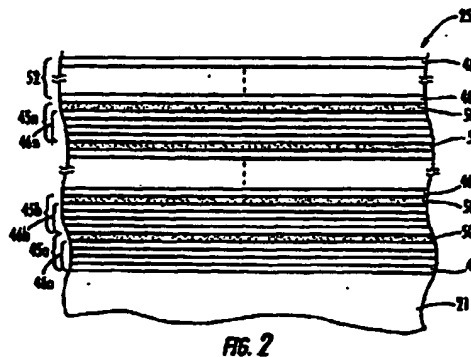
The title page showing the print figure should be deleted, and replaced with the attached amended title page.

On the title page, Item (56), References Cited,
Insert: "H01L 29/14" after "EP 0393135 11/1994"

In the Drawings	Delete: FIG. 1
	Insert: New FIG. 1



Delete: FIG. 2
Insert: New FIG. 2



UNITED STATES PATENT AND TRADEMARK OFFICE
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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

In the Drawings

Delete: FIG. 4
Insert: New FIG. 4

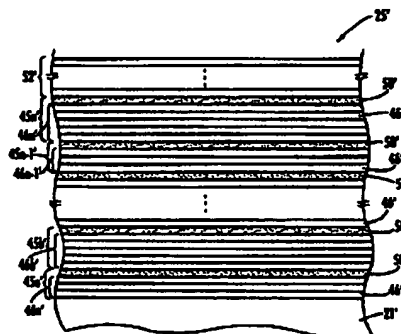


FIG. 4

Column 1, Line 67

Delete: "in a silicon"
Insert: --in silicon--

Column 2, Line 1

Delete: "electromuminescence"
Insert: --electroluminescence--

Column 2, Line 60

Delete: "superlattice and has"
Insert: --superlattice has--

Column 5, Line 14

Delete: "gate 35"
Insert: --gate 38--

Column 5, Line 62

Delete: "gate 35"
Insert: --gate 38--

Column 7, Line 66

Delete: "from the both"
Insert: --from both--

Column 9, Lines
of 46-48

Delete: "In other processes and devices the structures
the present invention may be formed on a portion of a
wafer or across substantially all of a wafer."

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Page 3 of 4

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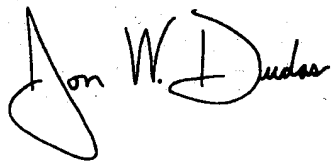
Column 9, Line 61

Delete: "also formed"

Insert: --also be formed--

Signed and Sealed this

Thirty-first Day of October, 2006

A handwritten signature in black ink, reading "Jon W. Dudas", is enclosed within a rectangular dashed-line box. The signature is written in a cursive, stylized script.

JON W. DUDAS
Director of the United States Patent and Trademark Office

(12) **United States Patent**
Mears et al.

(10) Patent No.: **US 6,878,576 B1**
(45) Date of Patent: **Apr. 12, 2005**

(54) **METHOD FOR MAKING SEMICONDUCTOR DEVICE INCLUDING BAND-ENGINEERED SUPERLATTICE**

5,357,119 A * 10/1994 Wang et al. 257/18

(Continued)

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(75) Inventors: Robert J. Mears, Wellesley, MA (US); Jean Augustin Chan Sow Fook Yiptong, Waltham, MA (US); Marek Hytha, Brookline, MA (US); Scott A. Kreps, Southborough, MA (US); Ilja Dukovski, Newton, MA (US)

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(73) Assignee: **RJ Mears, LLC, Waltham, MA (US)**

(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 0 days.

(21) Appl. No.: 10/716,991

(22) Filed: Nov. 19, 2003

Related U.S. Application Data

(63) Continuation of application No. 10/647,061, filed on Aug. 22, 2003, which is a continuation-in-part of application No. 10/603,696, filed on Jun. 26, 2003, and a continuation-in-part of application No. 10/603,621, filed on Jun. 26, 2003.

(51) Int. Cl.⁷ H01L 21/20

(52) U.S. Cl. 438/162; 438/479; 438/301

(58) Field of Search 438/22-47, 149-162, 438/217, 222-228, 229-301, 479-508

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Primary Examiner—Savitri Mulpuri

(74) Attorney, Agent, or Firm—Allen, Dyer, Doppelt, Milbrath & Gilchrist, P.A.

(57) **ABSTRACT**

A method is for making a semiconductor device by forming a superlattice that, in turn, includes a plurality of stacked groups of layers. The method may also include forming regions for causing transport of charge carriers through the superlattice in a parallel direction relative to the stacked groups of layers. Each group of the superlattice may include a plurality of stacked base semiconductor monolayers defining a base semiconductor portion and an energy band-modifying layer thereon. The energy-band modifying layer may include at least one non-semiconductor monolayer constrained within a crystal lattice of adjacent base semiconductor portions so that the superlattice may have a higher charge carrier mobility in the parallel direction than would otherwise occur. The superlattice may also have a common energy band structure therein.

36 Claims, 9 Drawing Sheets

